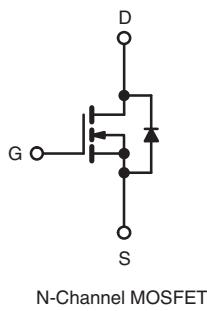
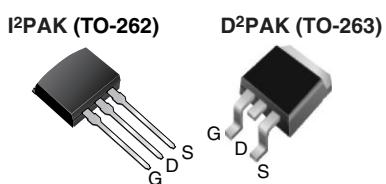


## Power MOSFET

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	500
R <sub>DSON</sub> (Max.) (Ω)	V <sub>GS</sub> = 10 V      3.0
Q <sub>G</sub> (Max.) (nC)	17
Q <sub>GS</sub> (nC)	4.3
Q <sub>GD</sub> (nC)	8.5
Configuration	Single



### FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Low Gate Charge Q<sub>G</sub> Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective C<sub>OSS</sub> specified
- Compliant to RoHS Directive 2002/95/EC



### APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching

### TYPICAL SMPS TOPOLOGIES

- Two Transistor Forward
- Half Bridge and Full Bridge

ORDERING INFORMATION			
Package	D²PAK (TO-263)	I²PAK (TO-262)	
Lead (Pb)-free and Halogen-free	SiHF820AS-GE3	SiHF820AL-GE3	
Lead (Pb)-free	IRF820ASPbF SiHF820AS-E3	IRF820ALPbF SiHF820AL-E3	

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V <sub>DS</sub>	500	V
Gate-Source Voltage		V <sub>GS</sub>	± 30	
Continuous Drain Current	V <sub>GS</sub> at 10 V	I <sub>D</sub>	2.5	A
			1.6	
Pulsed Drain Current <sup>a, e</sup>		I <sub>DM</sub>	10	
Linear Derating Factor			0.4	W/°C
Single Pulse Avalanche Energy <sup>b, e</sup>		E <sub>AS</sub>	140	mJ
Avalanche Current <sup>a</sup>		I <sub>AR</sub>	2.5	A
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	5.0	mJ
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	50	W
Peak Diode Recovery dV/dt <sup>c, e</sup>		dV/dt	3.4	V/ns
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	
Mounting Torque	6-32 or M3 screw		10	lbf · in
			1.1	N · m

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Starting T<sub>J</sub> = 25 °C, L = 45 mH, R<sub>g</sub> = 25 Ω, I<sub>AS</sub> = 2.5 A (see fig. 12).
- I<sub>SD</sub> ≤ 2.5 A, dI/dt ≤ 270 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C.
- 1.6 mm from case.
- Uses IRF820A, SiHF820A data and test conditions.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

**THERMAL RESISTANCE RATINGS**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB Mounted, steady-state) <sup>a</sup>	R <sub>thJA</sub>	-	62	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	2.5	

**Note**

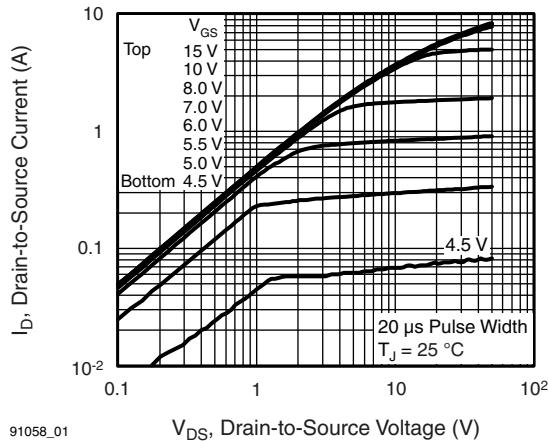
a. When mounted on 1" square PCB (FR-4 or G-10 material).

**SPECIFICATIONS** ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

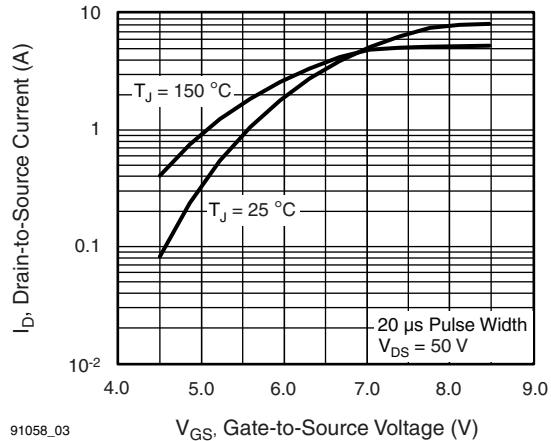
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = 250 μA		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	Reference to 25 °C, I <sub>D</sub> = 1 mA <sup>d</sup>		-	0.60	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		2.0	-	4.5	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 30 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	-	25	μA
		V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 1.5 A <sup>b</sup>	-	-	3.0	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 1.5 A <sup>d</sup>		1.4	-	-	S
<b>Dynamic</b>							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5 <sup>d</sup>		-	340	-	pF
Output Capacitance	C <sub>oss</sub>			-	53	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	2.7	-	
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 1.0 V, f = 1.0 MHz	-	490	-	nC
			V <sub>DS</sub> = 400 V, f = 1.0 MHz	-	15	-	
Effective Output Capacitance	C <sub>oss eff.</sub>		V <sub>DS</sub> = 0 V to 400 V <sup>c, d</sup>	-	28	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.5 A, V <sub>DS</sub> = 400 V, see fig. 6 and 13 <sup>b, d</sup>	-	-	17	ns
Gate-Source Charge	Q <sub>gs</sub>			-	-	4.3	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	8.5	
Turn-On Delay Time	t <sub>d(on)</sub>			-	8.1	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 2.5 A, R <sub>g</sub> = 21 Ω, R <sub>D</sub> = 97 Ω, see fig. 10 <sup>b, d</sup>	-	12	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>		-	16	-		
Fall Time	t <sub>f</sub>		-	13	-		
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.5	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	10	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 2.5 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 2.5 A, dI/dt = 100 A/μs <sup>b, d</sup>		-	330	500	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	760	1140	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					

**Notes**

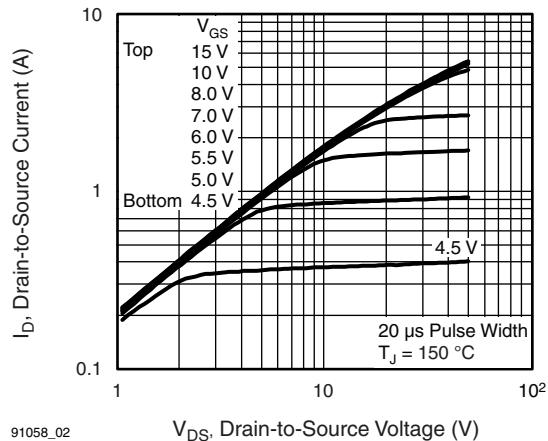
- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.
- c. C<sub>oss eff.</sub> is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 % to 80 % V<sub>DS</sub>.
- d. Uses IRF820A/SiHF820A data and test conditions.

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)


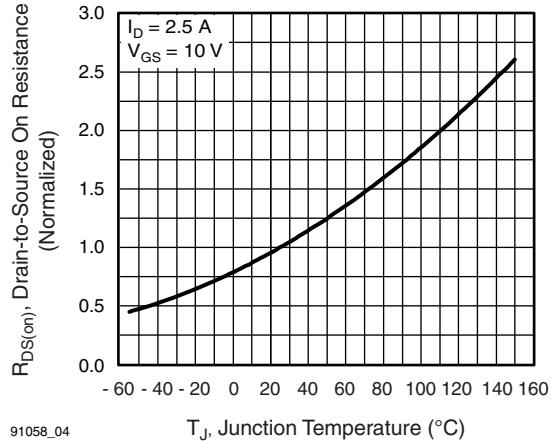
91058\_01

 $V_{DS}$ , Drain-to-Source Voltage (V)**Fig. 1 - Typical Output Characteristics**

91058\_03

 $V_{GS}$ , Gate-to-Source Voltage (V)**Fig. 3 - Typical Transfer Characteristics**

91058\_02

 $V_{DS}$ , Drain-to-Source Voltage (V)**Fig. 2 - Typical Output Characteristics**

91058\_04

 $T_J$ , Junction Temperature (°C)**Fig. 4 - Normalized On-Resistance vs. Temperature**

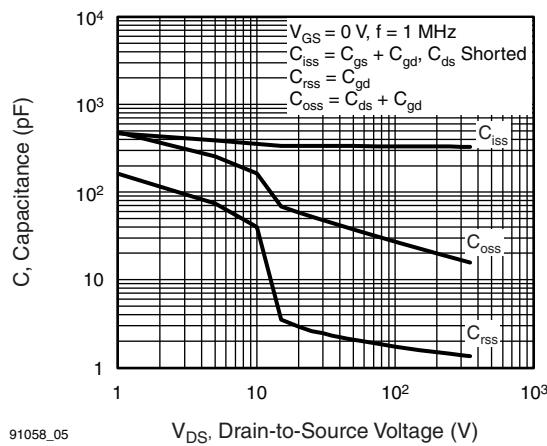


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

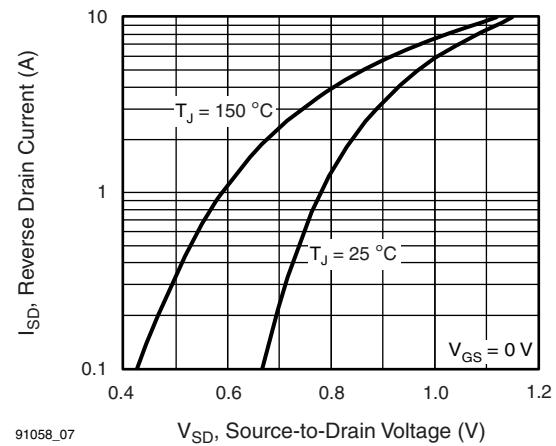


Fig. 7 - Typical Source-Drain Diode Forward Voltage

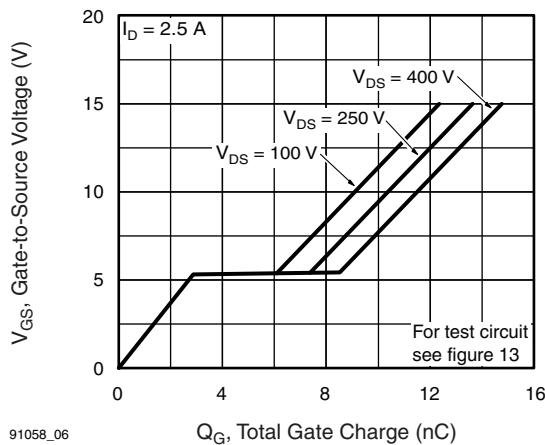


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

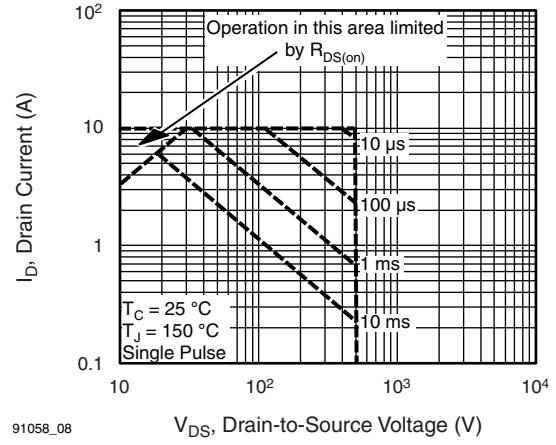
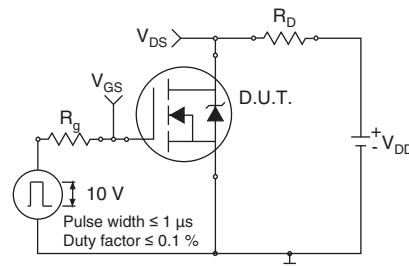
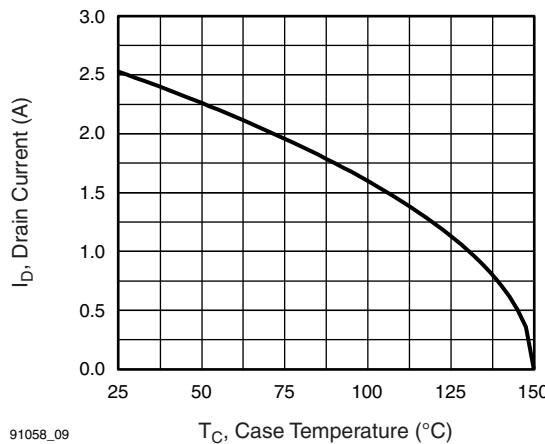
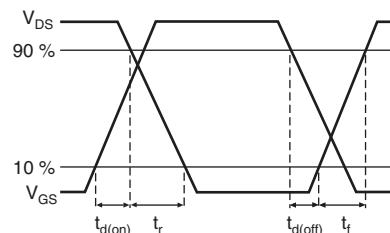
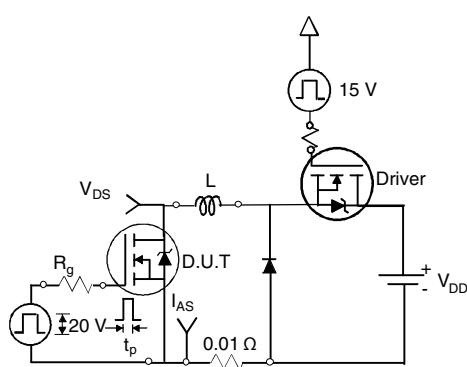
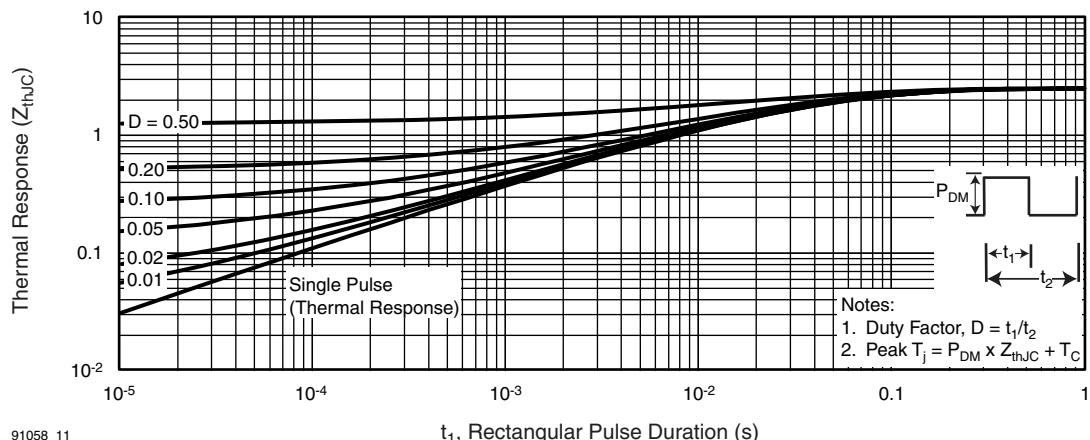
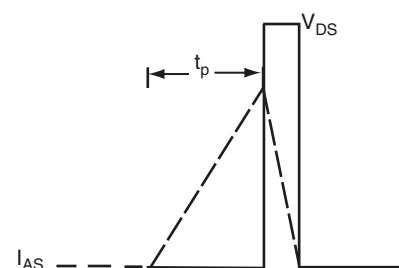
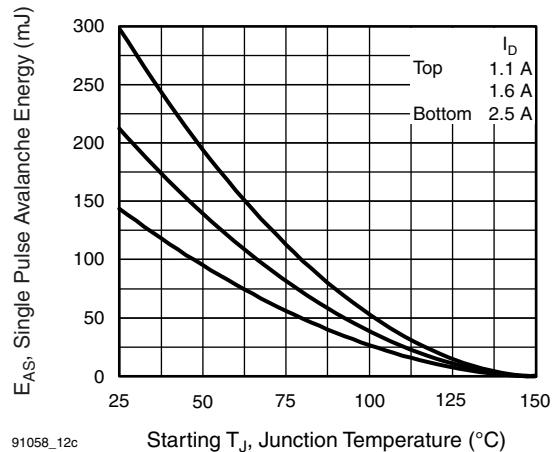
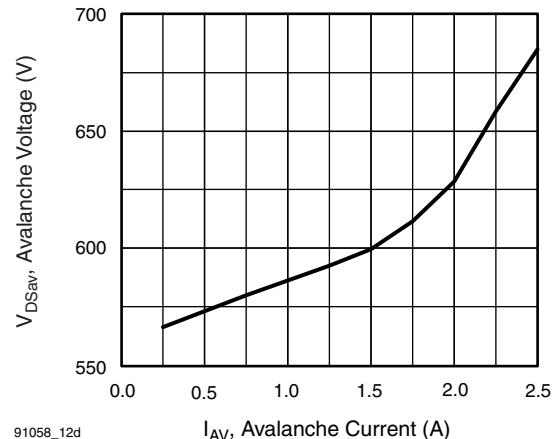


Fig. 8 - Maximum Safe Operating Area


**Fig. 10a - Switching Time Test Circuit**

**Fig. 10b - Switching Time Waveforms**

**Fig. 12a - Unclamped Inductive Test Circuit**

**Fig. 12b - Unclamped Inductive Waveforms**



91058\_12c Starting  $T_J$ , Junction Temperature (°C)



91058\_12d  $I_{AV}$ , Avalanche Current (A)

Fig. 12c - Maximum Avalanche Energy vs. Drain Current

Fig. 12d - Basic Gate Charge Waveform

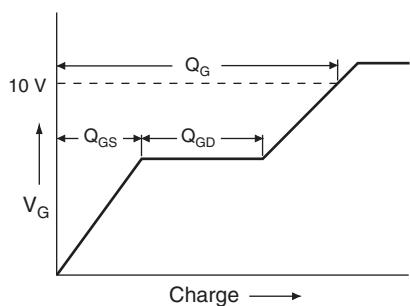


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

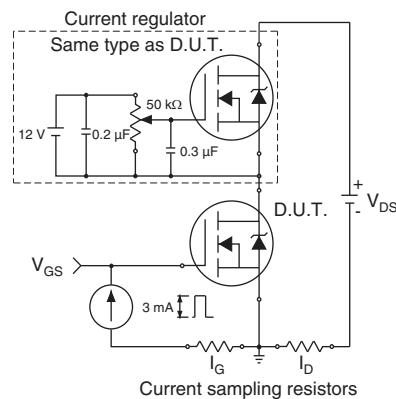
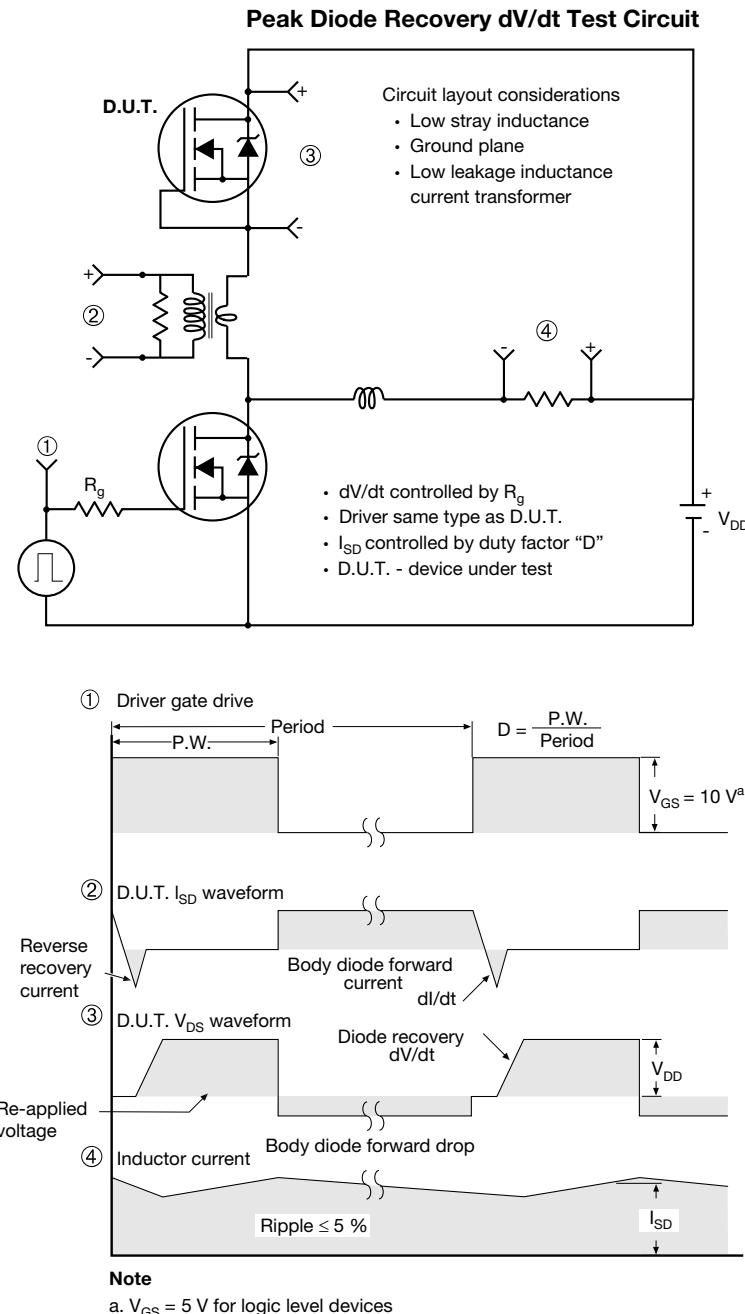


Fig. 13b - Gate Charge Test Circuit


**Fig. 14 - For N-Channel**

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### TO-263AB (HIGH VOLTAGE)



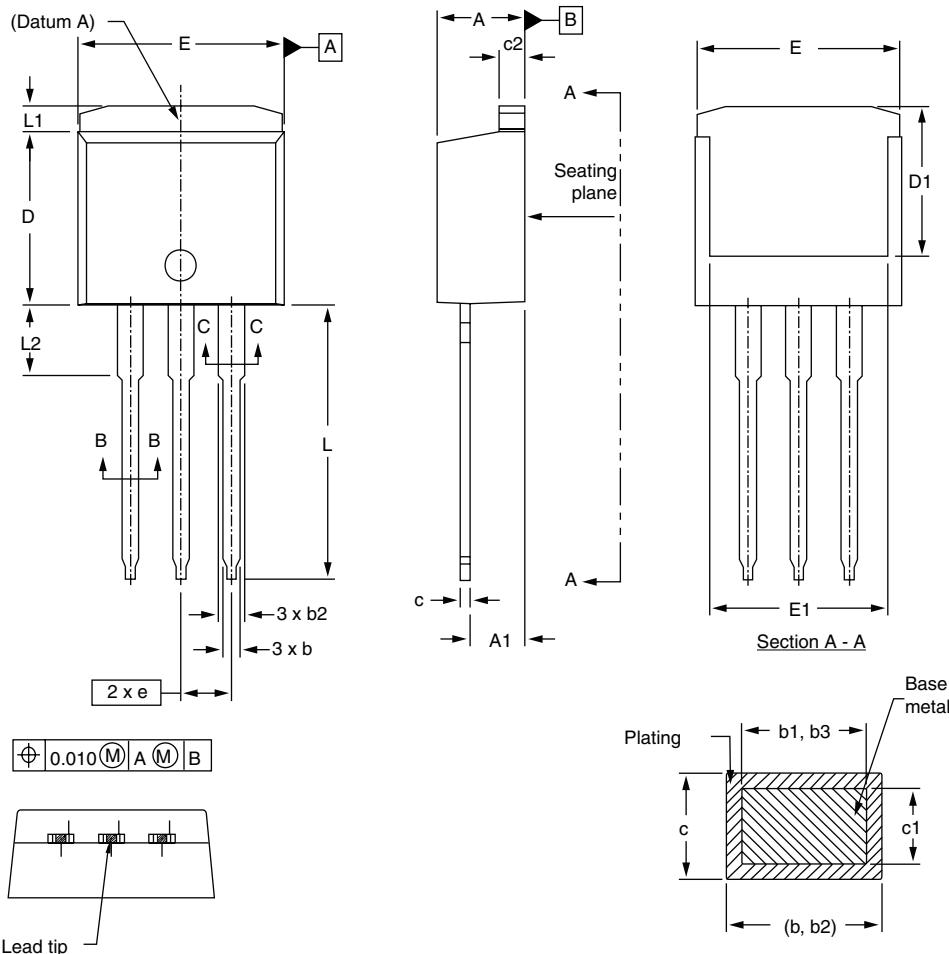
DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
c	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

ECN: S-82110-Rev. A, 15-Sep-08  
DWG: 5970

#### Notes

- Dimensioning and tolerancing per ASME Y14.5M-1994.
- Dimensions are shown in millimeters (inches).
- Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- Thermal PAD contour optional within dimension E, L1, D1 and E1.
- Dimension b1 and c1 apply to base metal only.
- Datum A and B to be determined at datum plane H.
- Outline conforms to JEDEC outline to TO-263AB.

### I<sup>2</sup>PAK (TO-262) (HIGH VOLTAGE)



Section B - B and C - C

Scale: None

DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.06	4.83	0.160	0.190
A1	2.03	3.02	0.080	0.119
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
c	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065

ECN: S-82442-Rev. A, 27-Oct-08

DWG: 5977

#### Notes

- Dimensioning and tolerancing per ASME Y14.5M-1994.
- Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- Thermal pad contour optional within dimension E, L1, D1, and E1.
- Dimension b1 and c1 apply to base metal only.

DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
e	2.54 BSC		0.100 BSC	
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146



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